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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/982,086	10/19/2001	Jeong-kwan Lee	1293.1270	6758
21171	7590	12/03/2003	EXAMINER	
STAAS & HALSEY LLP SUITE 700 1201 NEW YORK AVENUE, N.W. WASHINGTON, DC 20005			GEBREMARIAM, SAMUEL A	
			ART UNIT	PAPER NUMBER
			2811	

DATE MAILED: 12/03/2003

Please find below and/or attached an Office communication concerning this application or proceeding.

Office Action Summary

Application No.

Applicant(s)

09/982,086

LEE ET AL.

Examiner

Art Unit

Samuel A Gebremariam

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-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133).
- Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☒ Responsive to communication(s) filed on 03 September 2003.
- 2a) ☒ This action is **FINAL**. 2b) ☐ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☒ Claim(s) 1-64 is/are pending in the application.
- 4a) Of the above claim(s) _____ is/are withdrawn from consideration.
- 5) ☐ Claim(s) _____ is/are allowed.
- 6) ☒ Claim(s) 1-64 is/are rejected.
- 7) ☐ Claim(s) _____ is/are objected to.
- 8) ☐ Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☐ The drawing(s) filed on _____ is/are: a) ☐ accepted or b) ☐ objected to by the Examiner.
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. §§ 119 and 120

- 12) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
a) ☐ All b) ☐ Some * c) ☐ None of:
1. ☐ Certified copies of the priority documents have been received.
2. ☐ Certified copies of the priority documents have been received in Application No. _____.
3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).
* See the attached detailed Office action for a list of the certified copies not received.
- 13) ☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application) since a specific reference was included in the first sentence of the specification or in an Application Data Sheet. 37 CFR 1.78.
a) ☐ The translation of the foreign language provisional application has been received.
- 14) ☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121 since a specific reference was included in the first sentence of the specification or in an Application Data Sheet. 37 CFR 1.78.

Attachment(s)

- 1) ☐ Notice of References Cited (PTO-892)
- 2) ☐ Notice of Draftsperson's Patent Drawing Review (PTO-948)
- 3) ☒ Information Disclosure Statement(s) (PTO-1449) Paper No(s) 15.
- 4) ☐ Interview Summary (PTO-413) Paper No(s). _____
- 5) ☐ Notice of Informal Patent Application (PTO-152)
- 6) ☐ Other: _____

DETAILED ACTION

Claim Rejections - 35 USC § 103

1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

Claims 1-3, 5-9, 11-20 and 22-64 are rejected under 35 U.S.C. 103(a) as being unpatentable over admitted prior art in view of Jiang et al. US patent No. 5,966,399.

Regarding claim 1 admitted prior art teaches a vertical cavity surface emitting laser (VCSEL) comprising: a substrate (10); a lower reflector formed on the substrate (11); an active layer (12) formed on the lower reflector, generating light by a recombination of electrons and holes; an upper reflector (14) formed on the active layer comprising a lower reflectivity than that of the lower reflector, an upper electrode formed above the upper reflector excluding the window region; and a lower electrode formed underneath the substrate.

Admitted prior art does not explicitly teach a micro-lens comprising a single convex surface disposed in a window region through which the laser beam is emitted; a lens layer formed on the upper reflector with a transparent material transmitting a laser beam, the lens layer comprising the micro-lens.

Jiang teaches (fig. 1) a VCSEL with integrated lens with micro-lens region (44) comprising a single convex surface (central portion of 44) and lens layer (region of lens where light 12 is not coming out) on the upper reflector region (22).

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It would have been obvious to one of ordinary skill in the art at the time the invention was made to incorporate the microlens portion of Jiang's device into the structure of admitted prior art in order to focus and/or collimate laser emission (column 6, lines 57-63). Furthermore the broad claim language "comprising" does not preclude the convex surface from having more than one convex surface.

Regarding claim 2 admitted prior art teaches substantially the entire structure of claim 1 above except explicitly stating that the VCSEL satisfies a following relationship: $f = Rn_1/(n_2 - n_1)$ where f is a distance along an optical axis from a light generating region of the active layer to a vertex of the micro-lens, R is a radius of curvature of the micro-lens, n_1 is an effective refractive index of a medium on an optical path between the light generating region and the lens layer, and n_2 is a refractive index of a region towards which a light is emitted through the micro-lens.

The formula above is a well known in the art. Since the combined structure of admitted prior art and Jiang results in a structure identical to the claimed invention the VCSEL structure inherently satisfies the relationship above.

Regarding claim 3, admitted prior art teaches substantially the entire structure of claim 1 above including a high-resistance region (13) between the upper and lower reflectors relatively close to the active layer, the high-resistance region having an aperture at a center thereof through which a current flows (fig. 1, admitted prior art).

Regarding claims 5 and 11 admitted prior art teaches substantially the entire structure of claim 1 except explicitly stating that the micro-lens is formed by diffusion-limited etching.

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The limitation that the micro-lens is formed by diffusion-limited etching is considered a product-by-process claim. "[E]ven though product-by process claims are limited by and defined by the process, determination of patentability is based on the product itself. The patentability of a product does not depend on its method of production. If the product in the product-by-process claim is the same as or obvious from a product of the prior art, the claim is unpatentable even though the prior product was made by a different process." *In re Thorpe*, 777 F.2d 695, 698, 227 USPQ 964, 966 (Fed. Cir. 1985).

Regarding claims 6 and 7, admitted prior art teaches substantially the entire structure of claims 1-3 except explicitly stating the window region comprises a maximum width smaller than a size of light generated in the active layer emitted towards the window region, satisfying a Fraunhofer diffraction condition occurring in the window region is offset by a focusing power of the micro-lens, where the maximum width of the window region D and a focal length f of the micro-lens satisfy a relation:

$D = (2 \times 1.22 \lambda f)^{1/2}$ where λ is a wavelength of the laser beam emitted from the VCSEL.

Since the combined structure of admitted prior art and Jiang is identical to the claimed device the combined structure satisfies the Fraunhofer diffraction condition as claimed.

Regarding claims 8 and 9, admitted prior art teaches substantially the entire structure of claim 1 except explicitly stating that the high-resistance region according to claims 6 and 7, between the upper and lower reflectors, relatively close to the active

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layer, the high-resistance region comprising an aperture at a center thereof through which a current flows, the aperture of the high-resistance region comprising a maximum width greater than or approximately equal to the maximum width of the window region.

Parameters such as width in the art of semiconductor manufacturing process are subject to routine experimentation and optimization to achieve the desired device characteristics.

It would have been obvious to one of ordinary skill in the art at the time the invention was made to make the high-resistance region comprising a maximum width greater than or approximately equal to the maximum width of the window as claimed.

Regarding claims 12-15, 16, 17-21 and 22, admitted prior art teaches substantially the entire structure of claims 1-4, 5, 6-10 and 11, except explicitly stating that the substrate is now used for transmitting the laser beam and the substrate comprises the microlens.

It would have been obvious to one of ordinary skill in the art at the time the invention was made to invert the combined structure of admitted prior art and Jiang and form the lens and micro-lens in the lower portion of the combined structure, since it has been held that rearranging parts of the invention involves only routine skill in the art. In re Japikse, 86 USPQ 70.

Regarding claim 23-26 admitted prior art teaches substantially the entire structure of claims 1-3, 5, 6-9 including a microlens integrally formed on a laser beam-emitting surface of the VCSEL emitting a parallel light beam and disposed in a window

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region through which the light beam is emitted; a lens layer comprising the microlens and formed on the laser beam emitting surface of the VCSEL (Jiang, fig. 1).

Regarding claim 27 admitted prior art teaches substantially the entire structure of claims 1-3, 5, 6-9 and 23 except explicitly stating that the aperture is small where the current applied through the upper electrode passes a region on the active layer and the light beam is generated in a dot-sized region of the active layer.

Parameters such as size of the aperture and the area of the light beam generated on the active layer in the art of semiconductor manufacturing process are subject to routine experimentation and optimization to achieve the desired device characteristics.

It would have been obvious to one of ordinary skill to in the art at the time the invention was made to vary the size of the aperture and the light beam area on the active layer as claimed.

Regarding claim 28, admitted prior art teaches substantially the entire claimed structure of claims 1-3, 5, 6-9 and 23 including the micro-lens lies along a central optical axis of the light beam emitted from the VCSEL (fig. 1, Jiang).

Regarding claims 29-31 and 32, admitted prior art teaches substantially the entire claimed structure of claims 1-4, 5, 6-10 and 23 including the lower reflector, the active layer, and the upper reflector are sequentially stacked on the substrate, the lower reflector and the upper reflector are formed of alternating semiconductor compounds comprising different refractive indexes and the lower reflector is doped with the same n-

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type impurities and the upper reflector is doped with p-type impurities (fig. 1, page 2, paragraph 5, prior art).

Regarding claim 33, admitted prior art teaches substantially the entire claimed structure of claims 1-3, 5, 6-9 and 23 including the active layer is formed of GaAs according to a wavelength of the light beam (fig. 1, Jiang, col. 5, lines 41-64).

Regarding claims 34 and 36, admitted prior art teaches substantially the entire claimed structure of claims 1-3, 5, 6-9 and 23 except explicitly stating that the high-resistance region comprising an aperture at a center thereof through which current applied through the upper electrode flows and high-resistance region is formed by implantations of ions or by selective oxidation in a region of the upper reflector and the micro-lens comprises a convex surface formed by diffusion-limited etching.

The limitations that the high resistance as claimed is formed by implantation of ions or selective oxidation and the micro-lens is formed by diffusion-limited etching are considered a product-by-process claim. "[E]ven though product-by process claims are limited by and defined by the process, determination of patentability is based on the product itself. The patentability of a product does not depend on its method of production. If the product in the product-by-process claim is the same as or obvious from a product of the prior art, the claim is unpatentable even though the prior product was made by a different process." *In re Thorpe*, 777 F.2d 695, 698, 227 USPQ 964, 966 (Fed. Cir. 1985).

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Regarding claim 37 admitted prior art teaches substantially the entire claimed structure of claims 1-3, 5, 6-9 and 23 including the upper electrode is formed on top of the lens layer (fig. 1, Jiang).

Regarding claims 38–40 admitted prior art teaches substantially the entire claimed structure of claims 1-3, 5, 6-9 and 23 except explicitly stating that the distance along an optical axis from the light generating region to a vertex of the micro-lens is equal to a focal length of the micro-lens where the VCSEL satisfies a following relationship: $f = Rn_1/(n_2 - n_1)$ where f is a distance along an optical axis from the light generating region to the vertex of the micro-lens, R is a radius of curvature of the micro-lens, n_1 is an effective refractive index of a medium on an optical path between the light generating region and the lens layer, and n_2 is a refractive index of a region toward which the light beam is emitted through the micro-lens; and the VCSEL also satisfies a following relationship: $n_1/S_1 + n_2/S_2 = (n_2 - n_1)/R$ where S_1 is a distance from the light generating region of the active layer to a vertex of the micro-lens on the optical axis, S_2 is a distance from the vertex of the micro-lens to a second focal point of the micro-lens, n_1 is an effective refractive index of the medium from the upper reflector and the lens layer, and n_2 is a refractive index of a region toward which the light beam emitted through the micro-lens travels.

The formulas above are well known in the art. Since the combined structure of admitted prior art and Jiang results in a structure identical to the claimed invention the VCSEL structure inherently satisfies the relationships above.

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With regards to the limitation that the distance along an optical axis from the light-generating region to a vertex of the micro-lens is equal to a focal length of the micro-lens is within the scope of one having ordinary skill in the art to find the optimal distance as claimed through obvious and routine experimentation.

Regarding claim 41 admitted prior art teaches substantially the entire claimed structure of claims 1-3, 5, 6-9 and 23 above except explicitly stating a forward biased current is applied to the micro-lens built-in VCSEL through the upper and lower electrodes, the light beam comprising a particular wavelength through laser oscillation is transmitted through the upper reflector and the lens layer and is condensed by the micro-lens and emitted as the parallel laser beam.

The above claimed limitation is the way VCSEL fitted with a micro-lens operates under normal operation condition. Since the claimed structure is identical to the combined structure of admitted prior art and Jiang it inherently operates as claimed above.

Regarding claim 42-46 admitted prior art teaches substantially the entire claimed structure of claims 1-3, 5, 6-9, 12 and 23 above including the VCSEL is a top-emitting type VCSEL (fig. 1, Jiang).

The combined teaching of admitted prior art and Jiang does not explicitly teach the limitation that the micro-lens is formed in the window region of the substrate through which the light beam is condensed and emitted.

It would have been obvious to one of ordinary skill in the art at the time the invention was made to invert the combined structure of admitted prior art and Jiang and

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form the lens and micro-lens in the lower portion of the combined structure, since it has been held that rearranging parts of the invention involves only routine skill in the art. In re Japikse, 86 USPQ 70.

Regarding claims 47-48 admitted prior art teaches substantially the entire claimed structure of claims 1-4, 5, 6-10, 12 and 23 above including that when a number of stacked layers of the lower reflector is smaller than that of the upper reflector, the reflectivity of the lower reflector is lower than that of the upper reflector and most of the laser beam is emitted through the lower reflector.

The above limitation is inherent characteristics of a reflector structure. Therefore the combined structure of admitted prior art and Jiang have the claimed characteristic of the reflectors inherently.

Regarding claims 49-50, the combined teaching of admitted prior art, Shimada and Lee teaches substantially the entire claimed structure of claims 1-4, 5, 6-10, 12 and 23 above including the lower reflector and the upper reflector are formed of alternating semiconductor compounds comprising different refractive indexes (fig. 1, prior art).

Since the combined structure of admitted prior art and Jiang is identical to the claimed structure it inherently have the claimed property.

Regarding claim 51 admitted prior art teaches substantially the entire claimed structure of claims 1-3, 5, 6-9, 12 and 23 above except explicitly stating that the VCSEL satisfies a following relationship: $f = R' \times n1' / (n2' - n1')$ where R' is a radius of curvature of the micro-lens, $n1'$ is a effective refractive index of a medium along an optical path between the light generating region of the active layer and the micro-lens, and $n2'$ is a

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refractive index of a region toward which the light beam emits through the micro-lens, f is a distance from the light generating region to a vertex of the micro-lens along the optical axis.

The formula above is well known in the art. Since the combined structure of admitted prior art and Jiang results in a structure that is identical to the claimed invention the VCSEL structure inherently satisfies the relationship above.

Regarding claims 52 and 53 admitted prior art teaches substantially the entire claimed structure of claims 1-3, 5, 6-9, 12 and 23 above except explicitly stating that a forward biased current is applied to the micro-lens built-in VCSEL through the upper and lower electrodes, a laser beam comprising a particular wavelength through laser oscillation is transmitted through the lower reflector and the substrate and is condensed by the micro-lens and emitted as the parallel laser beam and the VCSEL is a bottom-emitting type VCSEL.

The above claimed limitation is the way VCSEL fitted with a micro-lens at the bottom operates under normal operation condition. Since the claimed structure is identical to the combined structure of admitted prior art, Shimada and Lee it inherently operates as claimed above.

Regarding claims 54 and 55 admitted prior art teaches substantially the entire claimed structure of claims 1-3, 5, 6-9, 12 and 23 above except explicitly stating that an upper reflector comprising a relatively lower reflectivity than that of the lower reflector.

Parameters such as reflectivity and size are variables that are subject to optimization through routine experimentation.

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It would have been obvious to one of ordinary skill in the art at the time the invention was made to vary the reflectivity as claimed in order to satisfy the Fraunhofer diffraction condition.

Regarding claims 56, 57 and 61 admitted prior art teaches substantially the entire claimed structure of claims 1-4, 5, 6-10, 12, 23 and 54 above except explicitly stating that the Fraunhofer diffraction condition of the window is offset by a focusing power of the micro-lens so that a parallel laser beam is emitted through the micro-lens the diameter D of the window and a focal length f of the micro-lens satisfy a following relationship: $D = (2 \times 1.22 \lambda f)^{1/2}$ where λ is a wavelength of the light beam emitted from the VCSEL and also a following relationship:

$N_f = D^2 / \lambda d \ll 1$; where N_f is a Fresnel number, λ , is a wavelength of the light beam emitted from the VCSEL, D is the diameter of the window, and d is a distance from the window to an observing plane, which is one focal point of the micro-lens.

Since the combined structure of admitted prior art and Jiang is identical to the claimed device the combined structure satisfies the Fraunhofer diffraction conditions as claimed.

Regarding claim 58, admitted prior art teaches substantially the entire claimed structure of claims 1-3, 5, 6-9, 12, 23 and 54 above including the high-resistance region between the upper and lower reflectors relatively close to the active layer, the high-resistance region comprises an aperture at the center thereof through which a current flows (fig. 1).

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Regarding claim 59 admitted prior art substantially the entire claimed structure of claims 1-3, 5, 6-9, 12, 23 and 54 above except explicitly stating that the diameter of the window is smaller than or approximately equal to a diameter of the aperture of the high-resistance region.

Parameters such as diameter and radius are variables that are subject to optimization through routine experimentation.

It would have been obvious to one of ordinary skill in the art at the time the invention was made to vary the diameter of the window as claimed.

Regarding claims 60 and 62 admitted prior art teaches substantially the entire claimed structure of claims 1-3, 5, 6-9, 12 and 23 above including the window and the micro-lens are positioned on a same and the micro-lens and the window are positioned on a same plane (fig. 1, Jiang).

Regarding claim 63 admitted prior art teaches substantially the entire claimed structure of claims 1-3, 5, 6-9, 12, 23 and 54 above except explicitly stating that when the micro-lens and the window are positioned on a same plane and only a O^{th} -order diffracted beam comprising a high intensity is considered, a radius R_s of the O^{th} -order diffracted beam satisfies a following relationship: $R_s = 1.22\lambda d / D$ where λ , is a wavelength of the light beam emitted from the VCSEL, D is the diameter of the window, and d is a distance from the window to an observing plane.

Since the combined structure of admitted prior art and Jiang is identical to the claimed device the combined structure satisfies the above relationship as claimed.

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Regarding claim 64 admitted prior art teaches substantially the entire claimed structure of claims 1-3, 5, 6-9, 12, 23 and 54 above including the VCSEL is a top-emitting type VCSEL (fig. 1, Jiang).

Claims 4, 10 and 21, are rejected under 35 U.S.C. 103(a) as being unpatentable over admitted prior art in view of Jiang and in further view of Peake et al. US patent No. 6,122,109.

Admitted prior art teaches substantially the entire structure of claims 1, 6 and 12 above except explicitly stating that the lens layer is formed of a material comprising at least one of silicon and a III-V compound semiconductor, wherein the III-V compound semiconductor comprises one of indium phosphide (InP), gallium arsenide (GaAs), indium arsenide (InAs), gallium phosphide (GaP), indium gallium phosphide (InGaP), indium gallium arsenide (InGaAs), and aluminum gallium arsenide (AlGaAs), the material comprising a relatively large bandgap to a wavelength of the laser beam so as not to absorb the laser beam.

It is conventional and also taught by Peake forming a microlens layer using GaAs (col. 6, line 46-53).

It would have been obvious to one of ordinary skill in the art at the time the invention was made to incorporate the microlens layer formed of GaAs taught by Peake in the structure of admitted prior art and Jiang.

Response to Arguments

2. Applicant's arguments with respect to claims 1-64 have been considered but they are not persuasive. Applicant argues that the Jiang reference has more than one

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convex surface, therefore does not teach the limitation of claim 1 "comprising a single convex surface". In response as outlined in claim 1, the center portion of the lens in Jiang reference (fig. 1) teaches a single convex surface. Furthermore the term comprising in the claim does not preclude the microlens structure from having more than one convex surface.

The transitional term "comprising", which is synonymous with "including," "containing," or "characterized by," is inclusive or open-ended and does not exclude additional, unrecited elements or method steps. See, e.g., *Genentech, Inc. v. Chiron Corp.*, 112 F.3d 495, 501, 42 USPQ2d 1608, 1613 (Fed. Cir. 1997) ("Comprising" is a term of art used in claim language which means that the named elements are essential, but other elements may be added and still form a construct within the scope of the claim.); *Moleculon Research Corp. v. CBS, Inc.*, 793 F.2d 1261, 229 USPQ 805 (Fed. Cir. 1986); *In re Baxter*, 656 F.2d 679, 686, 210 USPQ 795, 803 (CCPA 1981); *Ex parte Davis*, 80 USPQ 448, 450 (Bd. App. 1948) ("comprising" leaves "the claim open for the inclusion of unspecified ingredients even in major amounts").

With regards to claims 6 and 54 applicant argues that the concept of providing the window region comprises a maximum width smaller than a size of light generated in the active layer emitted towards the window region, satisfying a Fraunhofer diffraction condition, where the Fraunhofer diffraction condition occurring in the window region is offset by focusing power. Fraunhofer diffraction condition is well known in the art.

Therefore a person of ordinary skill in the art at the time the invention was made would be motivated to adjust the focal point of the combined structure of admitted prior art and Jiang optimize the lens power in order to increase the power of the VCSEL.

Conclusion

3. **THIS ACTION IS MADE FINAL.** Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

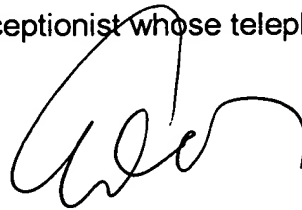
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A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Samuel Admassu Gebremariam whose telephone number is 703 305 1913. The examiner can normally be reached on 8:00am-4: 30pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Eddie Lee can be reached on (703) 305-1690. The fax phone numbers for the organization where this application or proceeding is assigned are (703) 308-7722 for regular communications and (703) 872-9306 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-0956.



EDDIE LEE
SUPERVISORY PATENT EXAMINER
TECHNOLOGY CENTER 2800

Samuel Admassu Gebremariam
December 1, 2003